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Indian Standard SPECIFICATION FOR PUSH-BUTTON SWITCHES

PART 2 PUSH-BUTTON SWITCHES, TYPE 1

(Incorporating Amendment No. 1)

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BUREAU OF INDIAN STANDARDS MANAK BHAVAN, 9 BAHADUR SHAH ZAFAR MARG NEW DELHI 110002

Price Group 4

Indian Standard

SPECIFICATION FOR **PUSH-BUTTON SWITCHES**

PART 2 PUSH-BUTTON SWITCHES, TYPE 1

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Indian Standard

SPECIFICATION FOR PUSH-BUTTON SWITCHES

PART 2 PUSH-BUTTON SWITCHES, TYPE 1

O. FOREWORD

- 0.1 This Indian Standard was adopted by the Indian Standards | Institution on 4 March 1986, after the draft finalized by the Electromechanical Components for Electronic Equipment Sectional Committee had been approved by the Electronics and Telecommunication Division Council.
- **0.2** The object of this standard (Part 2) is to specify detailed requirements for push-button switches. The general requirements for push-button switches are covered in IS: 4794 (Part 1)-1968*.
- **0.3** Some general notes on push-button switches covered by this standard are given in Appendix A.
- **0.4** This edition 1.1 incorporates Amendment No. 1 (July 1989). Side bar indicates modification of the text as the result of incorporation of the amendment.
- 0.5 For the purpose of deciding whether a particular requirement of this standard is complied with, the final value, observed or calculated, expressing the result of a test, shall be rounded off in accordance with IS: 2-1960†. The number of significant places retained in the rounded off value should be same as that of the specified value in this standard.

1. SCOPE

1.1 This standard (Part 2) covers requirements for push-button switches (Type 1) used in consumer electronics like wave band change switches in mains/transistorized battery operated radio receivers.

2. TERMINOLOGY

2.1 For the purpose of this standard, the definititions given in 2 of IS: 4794 (Part 1)-1968* shall apply.

^{*}Specification for push-button switches: Part 1 General requirements and tests.

[†]Rules for rounding off numerical values (revised).

3. CATEGORIES

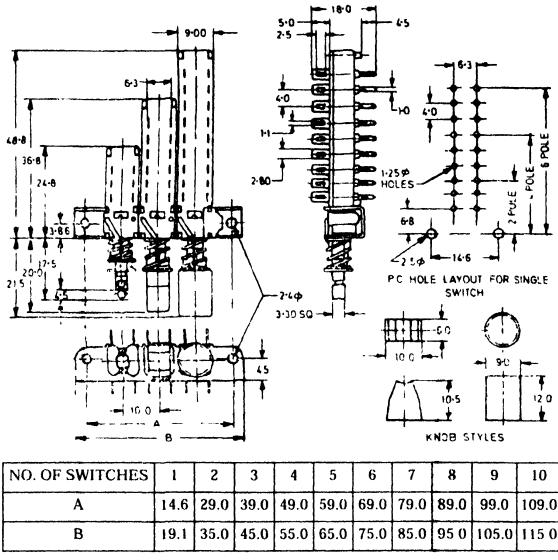
3.1 Provisions of category 3 of IS: 4794 (Part 1)-1968* shall apply.

4. ELECTRICAL RATINGS

- 4.1 The ratings shall be as given below:
 - a) Voltage ratings $-> 24 \text{ V but } \leq 500 \text{ V (dc)}$.
 - b) Current ratings $-\le 1$ A.

5. MOUNTING DIMENSIONS

5.1 The mounting dimensions are given in Fig. 1.



All dimensions in millimetres.

FIG. 1 DIMENSIONAL DETAILS (TYPICAL) OF PUSH-BUTTON SWITCH

^{*}Specification for push button switches: Part I General requirements and tests.

6. MATERIALS AND WORKMANSHIP

6.1 Provisions of 5 of IS: 4794 (Part 1)-1968* shall apply.

7. MARKING

7.1 Provisions of 6 of IS: 4794 (Part 1)-1968* shall apply.

8. CONDITIONS FOR TESTS

- **8.1 Classification of Tests** Provisions of **7.1** of IS: 4794 (Part 1)-1968* shall apply.
- **8.2 General Conditions for Tests** Provisions of **7.2** of IS : 4794 (Part 1)-1968* shall apply.

9. REQUIREMENTS

- 9.1 The requirements shall be verified according to the relevant clauses of IS: 4794 (Part 1)-1968*.
- **9.2** The requirements for push-button switches shall be as given in Table 1.

	TABLE 1	REQUIREMENTS FOR PUSH-BU	TTON SWITCHES
SL No.	Tesi	CONDITIONS OF TEST	Requirement
MEC	CHANICAL		
i)	Robustness of terminations		There shall be no sign of mechanical damage or loosening of parts and the switch shall be mechanically operatable
ii)	Tensile test	An axial load of 20 N shall be applied for 10 s	No change in contact resistance
iii)	Bending test	Two consecutive bends at 90° shall be given	No change in contact resistance
iv)	Solderability of terminations	This shall be checked by dipping the terminations in solder bath. Solder bath temperature 230 ± 10°C, duration 2 ± 0.5 s for PCB and 270 ± 10°C, 4 s for hand soldering	There shall be a good flow of solder
			(Continued)

^{*}Specification for push-button switches: Part 1 General requirements and tests.

Т	ABLE 1 REQUIRE	MENTS FOR PUSH BUTTO	N SWITCHES — Contd
St No	TEST	CONDITIONS OF TEST	REQUIREMENT
v)	Thermal shock	This shall be checked by touching the termina tions by a soldering iron	There shall be no sign of mechanical damage or loosening of parts and the switch shall be mechanically operable
		Temperature 350 ± 10°C Duration 35±05s	No change in contact resistance
vi)	Operating torque/ force	Switch should be suitably mounted	8 N <i>Max</i> 4 N <i>Min</i>
vii)	Fnd steps torque/ force	A force of 50 N shall be applied against stops	There shall be no sign of mechanical damage or loosening of parts and the switch shall be mechanically operable No change in contact resistance
viii)			06-09N
FLFC	ΓRICAL	The switch should be soldered to PCB for PB mounting type Other switches should be suitably mounted	
i)	Contact resistance	The switches shall be fully operated three times on no load before measurement. The contact resistance shall then be measured across each pair of terminations at a current ≤ 1 A and from a source whose open circuit voltage is ≤ 2.5 V dc	≤ 10 m ohm
ii)	Insulati o n resistance	The insulation resistance shall be measured after electrification for 1 min by a dc potential of 100 ± 15 V. The insulation resistance shall be measured between the following points.	
		a) two adjacent termi nations having mini mum spacing and	≥1 00 0 Mohm
		b) all terminations con nected together and all other exposed metal parts	≥i 00 0 Mohm
		metar paris	(Continued)

TABLE 1 REQUIREMENTS FOR PUSH-BUTTON SWITCHES — Contd

SL No.	TEST	CONDITIONS OF TEST	REQUIRFMENT
iii)	Voltage proof (high voltage)	1 000 V rms shall be applied for one minute between points indicated in (ii)	No breakdown or flash over
iv)	Capacitance	The capacitance shall be measured at 1 MHz between	
		 a) individual terminations forming a part of a circuit but not in electrical contact, and 	≤ 1.5 pF
		b) individual termina- tions and all other terminations connec- ted to the frame	≤ 2 pF
v)	RF shunt resistance	The resistance shall be measured at 1 MHz between	
		a) two terminations whose contacts are open, and	> 2 Mohm
		b) one termination and all other terminations which are connected to earth	> 2 Mohm
vi)	Vibration	The switches shall be mounted and fastened rigidly to a suitable test jig. The test jig shall be vibrated in three different directions mutually perpendicular to each other, under one of the two conditions given below.	a) No visible damage b) Maximum change in contact resistance ≤ ± 50 percent of original value
		A circuit with a lamp shall be connected to switch.	No momentary switching operations during the test
			(Continued)

TABLE 1 REQUIREMENTS FOR PUSH-BUTTON SWITCHE					N SWITCHES — Contd
SL No.	T	FST	CONDITIONS	OF TEST	RLQUIREMENT
			Displacement P	0.75 mm (10 g) for ortable sets	
			Displacement to	0.35 mm (5 g) for able models	
			Approximate sw	veep time	l min
			Frequency rang	e linear	10-55-10 Hz
			Number of swe each of three of		For portable sets 120 For table models 30
			Approximate to	tal time	For portable sets — 6 h For table models — 1 5 h
vii)	Bumping	:	The switches mounted on test mach connected in mentioned in	ine and a circuit as	No momentary switching operation during test No visible damage
			No. of bumps : Acceleration	4 000 ± 10 : 390 m/s ² (40 g)	Maximum change in contact resistance ≤ ± 50 percent of original values
			Pulse duration	. 6 ms	
					(Continued)

SL TEST NO.		CONI	DITIONS O	F TEST		REQUIREMENT
vo.		Relative Humidity	Dura tion	Reco- very Time	Characteris- tics to be C h e c k e d After Test	
i) Climatic Sequence This test shall be performed on the same samples in the following sequence:						
a) Dry heat	+ 70°C ± 3°C	50 percent	16 h	0	Insulation resistance	> 1 000 Mohm
				1.5 ± 0 5 h	Operating force	< 20 N
b) Damp heat (cyclic) (first cycle)	to	percent	12 ± ½h } 12 ± ½h }	1.5 + 0 5 h	Visual ins pection	No corrosion of mechanical deterioration or any other visibledamage
c) Cold	- 10°C		4 h	0	1) Switch operation	Mechanically and electres cally operab
				1.5 ± 0 5 h	Visual ins pection	No sign deterioration
d) Damp heat (cyclic) (remaining cycles)		93 ± 3 percent	12 ± ½h	1.5 ± 0.5 h	1) Insulation resistance 2) Voltage proof 3) Contact resistance 4) Operating force 5) Visual inspection	1) > 100 Mohm 2) No flashove breakdown 3) ≤ 10 Mohm ± 50 percent 4) 8 N, Max 4 N, Min 5) No corrosion or any oth visible dar age
		≥ 95 per- cent	12 ± ½h	24 h	Insulation resistance	> 100 Mohm
						(Continued

	TABLE 1	REC	QUIREM	ENTS FOR	PUSH E	BUTTC	N SWITCHE	S — Contd
SL	TESI			CONDITIO	ONS OF T	FST		REQUIREMENT
NO.			Relative Humi dity	Load Polar izing Volt age dc	Dur ation	Reco very Period	Character istics to be Checked	
ii)	Damp hear (steady state)	t						
	Sample I	40 ± 2°C	percent	15 Vdc bet ween two adjacent ter mination having mini mum spacing	24 h		1) Insulation2) Voltage proof3) Contact resistance	> 100 Mohm No flashover or breakdown Initial resi stance ± 50 percent of initial resis tance subject to ≤ 10 mohms
							4) Visual ex amination	No corrosion or any other visible dam age
	Sample II	do	do	15 Vdc bet ween all ter minations connected to gether and all other metal parts	-	do	 Insulation resistance Voltage proof Contact resistance 	> 100 Mohm No flashover or breakdown Initial resistance ± 50 percent of initial resistance subject to ≤ 10 mohms
							4) Operating force	8 N, <i>Max</i> 4 N, <i>Min</i>
	Sample III	do	do	••	do	do	do	do
iii)	Rapidcha nge of tempera	+70°C to -10°C		-	30 min, change over	10± 05h	1) Insulation resistance	> 100 Mohm
	ture (5 rycles)	-10 C			time 3 min		2) Voltage proof 3) Contact resistance	No flashover or breakdown Initial resis tance ± 50 percent of initial resis tance, subject to≤10 mohms
							4) Visual inspection	No visible damage
								(Continued)

	TABLE 1 RE	QUIREMENTS FOR PUS	H-BUTTON SWITC	HES — Contd
SL No.	Tesi	TFST CONDITION	CHARACIFRISTICS TO BE MFASURED	RFQUIRFMENT
ENI	DURANCE			
i)	With load	The switches shall be operated mechanically to	1) Insulation resistance	> 1 000 Mohm
		make and break the main contacts 10 000		No flashover or breakdown
		times for independent version and 1 6000 times for interdependent ver-	tance	10 Mohms initial and 50 Mohms after life
		sion The switch should be mounted on PCB. The frequency of swit- ching for this test shall be between 9 to 15	4) Functional check	Mechanically and electrically operable. No objectionable crackle
		complete switching cycle per minute. The test shall be carried out using a resistive circuit with 30 V (dc) and 100 mA	5) Visual exami nation	No damage
ii)	With temperature tes	- The following test shall t be carried out:	1) Insulation resistance	> 1 000 Mohm
	(without load)	mounted on PCB. The		No flashover or breakdown
		frequency of switching for this test shall be		≤ 20 mohm
		between 9 to 15 com plete switching cycle per minute		Mechanically and electrically operable. No objectionable crackle in 3 cm dropcheck
		8 000 times switching + storage for 72 h at 70°C + 1 000 times switch ing +storage for 72 h at - 10°C + 7 000 times switching	5) Visual examina- tion	No damage
iii)	With humidity test (withou	y The following test shall	1) Insulation resistance	> 100 Mohm
	load)		2) Voltage proof	No flashover or breakdown
		The switch shall be mounted on PC board	3) Contact resistance	≤ 20 Mohm
				(Continued)

	TABLE 1	REQUIREMENTS FOR PUS	H BUTTON SWITC	HES — (ontd
SL No		TEST CONDITION	CHARACTERISTICS 10 BF MI ASURED	REQUIREMENT
		The frequency of switching shall be between 9 to 15 complete cycles/m	4) Functional check	Mechanically and electrically ope rable. No objectionable crackle in 3 cm drop check.
		8 000 times switching + storage for 500 h under 40°C, 90 95 percent relative humidity condition + 8 000 times switching	5) Visual check	No visible dam age

APPENDIX A

(Clause 0 2)

GENERAL NOTES ON PUSH-BUTTON SWITCHES

- A-1. Packaging for the switches should be such that no damage occurs to switch during its handling in transit
- A 2. It should be possible to mount switches of PB mounting type without the help of any auxiliary tools Switches should be calibrated to the required mounting spacing
- A-3. Switches for connecting to the supply mains shall fulfil the safety requirements as specified in IS 616 1981*
- A-4. Sequence of type approval shall be according to Appendix B.

^{*}Safety requirements for mains operated electronic and related apparatus for house hold and similar general use (*first revision*)

APPENDIX B

(Clause A-4)

SEQUENCE OF TYPE TESTS (MINIMUM NUMBER OF SAMPLES 24)

All 24 Samples

Visual examination
Dimensions
Contact resistance
Insulation resistance
Voltage proof
Capacitance

First Lot (8 Samples) Operating force Second Lot (8 Samples) Damp heat (steady state) Third Lot
(8 Samples)
Endurance
4 samples with load

End stop force

Robustness of termination
Soldering

4 samples without load
2 samples each with each load condition

2 samples with temperature test 2 samples with humidity test

Vibration Bumping

Rapid change of temperature

Climatic sequence

Criteria for Approval — The components shall be considered to satisfy the type tests if each sample tested passes the test or tests to which it is subjected.

Rejection and Re-testing — In case of failure in any one test, the requirements of type approval may be considered as not having been satisfied and fresh samples not exceeding the original number may be called for to undergo repeat tests. In such cases, a detailed report on the tests carried out shall be furnished. Fresh samples may be submitted after incorporating in the switches, any modifications, if considered necessary. The specific test or tests to be carried out on the fresh samples shall be decided by the testing authority who may wish to carry out all the related tests whether or not the earlier samples passed these tests satisfactorily. If, in the repeat test(s), no single failure occurs, the type shall be considered to be eligible for approval.

INTERNATIONAL SYSTEM OF UNITS (SI UNITS)

Base Units

Frequency

Electric conductance

Electromotive force

Pressure, stress

QUANTITY	UNIT	SYMBOL	
Length	metre	m	
Mass	kilogram	kg	
Time	second	5	
Electric current	ampere	Α	
Thermodynamic temperature	kelvin	K	
Luminous intensity	candela	cd	
Amount of substance	mole	mol	
Supplementary Units			
QUANTITY	Unit	SYMBOL	
Plane angle	radian	rad	
Solid angle	steradian	sr	
Derived Units			
QUANTITY	UNIT	SYMBOL	DEFINITION
Force	newton	N	$1 N = 1 kg m/s^2$
Energy	joule	J	1 J = 1 N.m
Power	watt	W	1 W = 1 J/s
Flux	weber	Wb	1 Wb = 1 V.s
Flux density	tesla	T	$1 T = 1 \text{ Wb/m}^2$

hertz

volt

pascal

siemens

 $1 \text{ Hz} = 1 \text{ c/s (s}^{-1})$

1 S = 1 A/V

1 V = 1 W/A

 $1 \text{ Pa} = 1 \text{ N/m}^2$

Hz

Pa

S V

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